

IGBT Chip in NPT-technology

FEATURES:

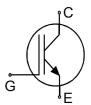
- 1200V NPT technology
- 180µm chip
- short circuit prove
- positive temperature coefficient
- easy paralleling

This chip is used for:

• IGBT-Modules BSM150GB120DLC

Applications:

drives



Chip Type	V _{CE}	I _{Cn}	Die Size	Package	Ordering Code
SIGC223T120R2CL	1200V	150A	14.4 x 15.5 mm ²	sawn on foil	Q67050-A4286- A101

MECHANICAL PARAMETER:

Raster size	14.4 x 15.5	mm ²			
Area total / active	223.2 / 189.9				
Emitter pad size	See chip drawing				
Gate pad size	1.518 x 1.496				
Thickness	180	μm			
Wafer size	150	mm			
Flat position	90	deg			
Max.possible chips per wafer	54 pcs				
Passivation frontside	Photoimide				
Emitter metalization	3200 nm Al Si 1%				
Collector metalization	alization 1400 nm Ni Ag –system suitable for epoxy and soft solder die bondin				
Die bond	electrically conductive glue or solder				
Wire bond	Al, ≤500μm				
Reject Ink Dot Size	Ø 0.65mm ; max 1.2mm				
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C				



MAXIMUM RATINGS:

Parameter	Symbol	Value	Unit
Collector-emitter voltage, <i>T</i> _j =25 °C	V _{CE}	1200	V
DC collector current, limited by T _{jmax}	Ic	1)	Α
Pulsed collector current, t _p limited by T _{jmax}	I _{cpuls}	450	Α
Gate emitter voltage	V _{GE}	±20	V
Operating junction and storage temperature	T_j , T_{stg}	-55 + 150	°C

¹⁾ depending on thermal properties of assembly

STATIC CHARACTERISTICS (tested on chip), T_j =25 °C, unless otherwise specified:

Parameter	Symbol	Conditions	Value			Unit
i didilietei		Conditions	min.	typ.	max.	
Collector-emitter breakdown voltage	V _{(BR)CES}	V_{GE} =0V , I_{C} =8 mA	1200			
Collector-emitter saturation voltage	V _{CE(sat)}	V _{GE} =15V, I _C =150A	1.8	2.2	2.6	V
Gate-emitter threshold voltage	$V_{\rm GE(th)}$	I _C =6mA , V _{GE} =V _{CE}	4.5	5.5	6.5	
Zero gate voltage collector current	I _{CES}	V _{CE} =1200V , V _{GE} =0V			18.2	μA
Gate-emitter leakage current	I _{GES}	V _{CE} =0V , V _{GE} =20V			600	nA

DYNAMIC CHARACTERISTICS (tested at component):

Parameter	Symbol	Conditions	Value			Unit
Farailleter			min.	typ.	max.	Uill
Input capacitance	Ciss	V _{CE} =25V,	-	11	-	nF
Output capacitance	Coss	$V_{GE}=0V$,	-	-	-	
Reverse transfer capacitance	Crss	f=1MHz	-	0.7	-	

SWITCHING CHARACTERISTICS (tested at component), Inductive Load:

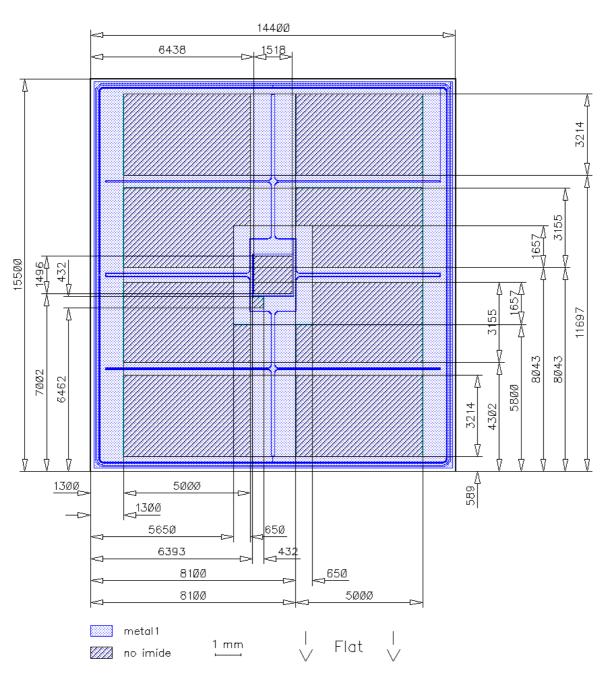
Parameter	Symbol	Conditions 1)	Value			Unit
- arameter	Syllibol	Conditions	min.	typ.	max.	Oilit
Turn-on delay time	$t_{d(on)}$	$T_{\rm j}$ =125°C $V_{\rm CC}$ =600V,	-	50	-	ns
Rise time	$t_{\rm r}$	$I_{\rm C}$ =150A	-	50	-	
Turn-off delay time	$t_{d(off)}$	$V_{\rm GE}$ =±15V, $R_{\rm G}$ =5.6 Ω	-	570	-	
Fall time	t_{f}	/\(\(\text{G} = \text{3.032}\)	-	40	-	

¹⁾ values also influenced by parasitic L- and C- in measurement and package.



CHIP DRAWING:

Die-Size 14400 um x 15500 um





FURTHER ELECTRICAL CHARACTERISTICS:

This chip data sheet refers to the device data sheet

BSM150GB120DLC

Half-Bridge 62mm

Description:

AQL 0,65 for visual inspection according to failure catalog

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Test-Normen Villach/Prüffeld

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